

# *Operational research for urban solar development*

*“PV failure detection based on operational time series”*

09/12/2024

Alexandre Mathieu



## Curriculum Plan

| Day                                   | Time                       | Duration    | Content                                |
|---------------------------------------|----------------------------|-------------|--|
| <b>Wednesday</b><br><b>13/11/2024</b> | 11h15-12h45<br>14h15-15h45 | 1h30 + 1h30 | 50% Lecture / 50 %<br>Hands-on         |
| <b>Tuesday</b><br><b>26/11/2024</b>   | 9h45-13h00                 | 1h30 + 1h30 | 25% Lecture / 75 %<br>Hands-on         |
| <b>Monday</b><br><b>02/12/2024</b>    | 13h15-16h15                | 3h          | 15% Lecture / 85 %<br>Hands-on         |
| <b>Monday</b><br><b>09/12/2024</b>    | 8h-11h<br>13h15-16h15      | 6h          | 10% Lecture / 90 %<br>Hands-on/Project |
| <b>Tuesday</b><br><b>10/12/2024</b>   | 8h-11h                     | 3h          | 10% Lecture / 90 %<br>Project          |
| <b>Monday</b><br><b>16/12/2024</b>    | 8-11h                      | 3h          | 10% Lecture / 90 %<br>Project          |
| <b>Thursday</b><br><b>19/12/2024</b>  | 9h45-12h45                 | 3h          | 10% Lecture / 90 %<br>Project          |
| <b>Monday</b><br><b>06/01/2025</b>    | 13h15-14h45                | 1h30        | 100% Project                           |
| <b>Monday</b><br><b>13/01/2025</b>    | 9h45-11h45                 | 1h30        | 100% Project                           |
| <b>Total</b>                          |                            | <b>27h</b>  |  |

# Agenda



**Review notebook last week**

**PV performance model steps**

# Agenda



**Review notebook last week**

PV performance model steps

# Review first notebook

## **Notebook recap 02/12/2024**

Google collab link: [https://colab.research.google.com/drive/1ncPYAOFvJvU\\_Tc5goPQL9F9wLNUh1FzQ?usp=sharing](https://colab.research.google.com/drive/1ncPYAOFvJvU_Tc5goPQL9F9wLNUh1FzQ?usp=sharing)

Correction: [https://github.com/AlexandreHugoMathieu/pvfault\\_detection\\_solar\\_academy/blob/master/notebooks/ac\\_power\\_estimation.ipynb](https://github.com/AlexandreHugoMathieu/pvfault_detection_solar_academy/blob/master/notebooks/ac_power_estimation.ipynb)

## Modeling steps

**Notebook recap 02/02/2024**

Python commands

```
import matplotlib.pyplot as plt
```

```
!pip install pvlib # In google collab, download the pvlib package
```

```
# Make a figure with one axis
```

```
fig, ax = plt.subplots(1, 1, figsize=(9,6))
```

```
df.plot(ax=ax) # Plot df (pd.Series or pd.DataFrame) on the axis "ax"
```

```
# Make a figure with two axes (two figures top/bottom) which share the same x axis
```

```
fig, (ax1, ax2) = plt.subplots(2, 1, figsize=(9,6), sharex=True)
```

```
# Force values to be between 0 and 1 (any value lower than 0 will be changed to 0 and any value higher than 1 will be adjusted down to 1)
```

```
# "eta" must be a pd.Series or pd.DataFrame to apply the ".clip()" method
```

```
eta = eta.clip(lower=0, upper=1)
```

```
# Select all df values between two dates: 10/06/2020 & 15/06/2020 in this case
```

```
# The index must be "DateTime" index
```

```
df.loc["20200610":"20200615"]
```

# Agenda

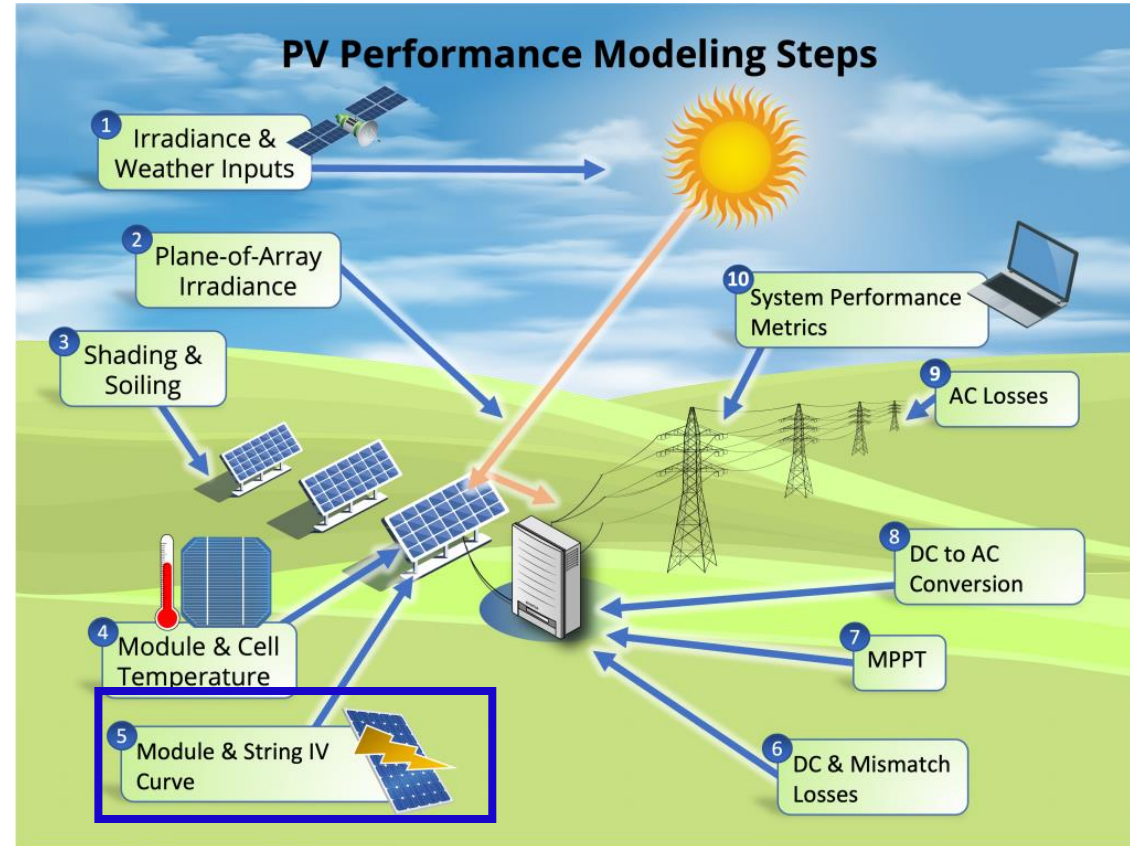


Review notebook last week

**PV performance model steps**

# Modeling steps

## 5. Module and String IV Curve

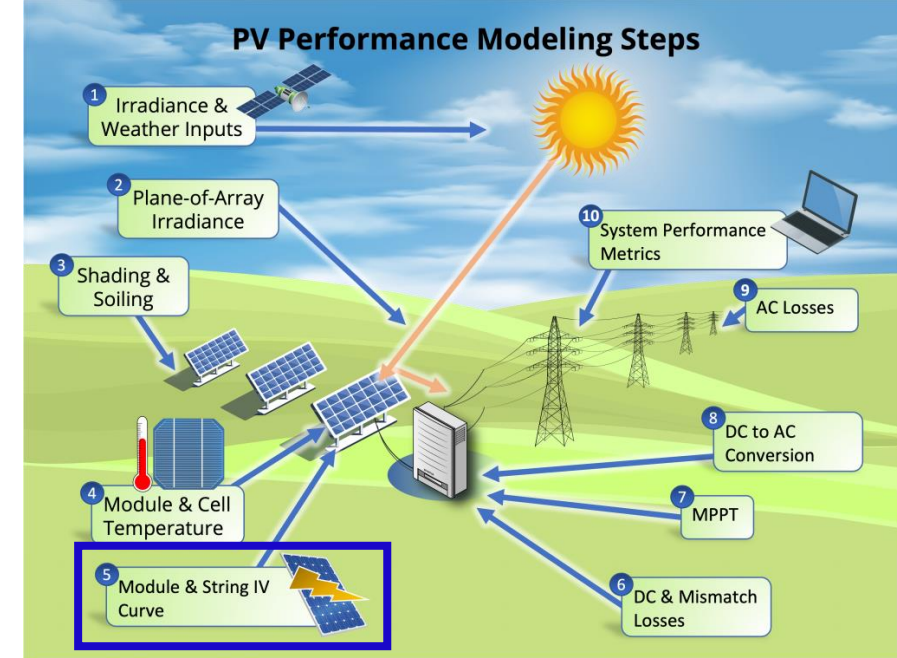
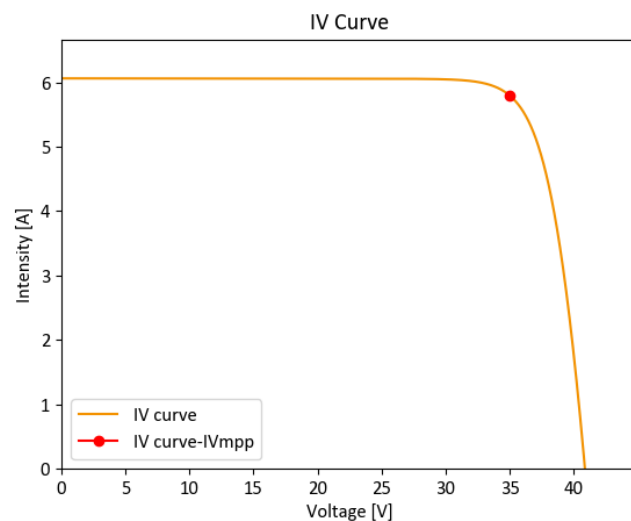




# Modeling steps

## 5. Module and String IV Curve

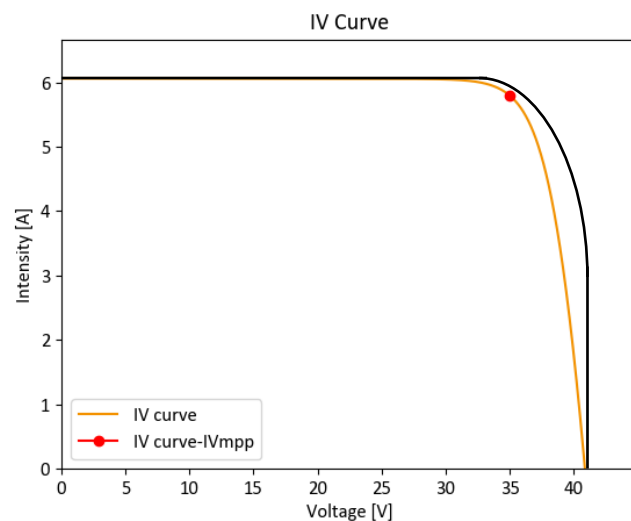
For a fixed irradiance and module temperature, the PV module has its  $I$ , current which depends on  $V$ , voltage and it can take many operating points.



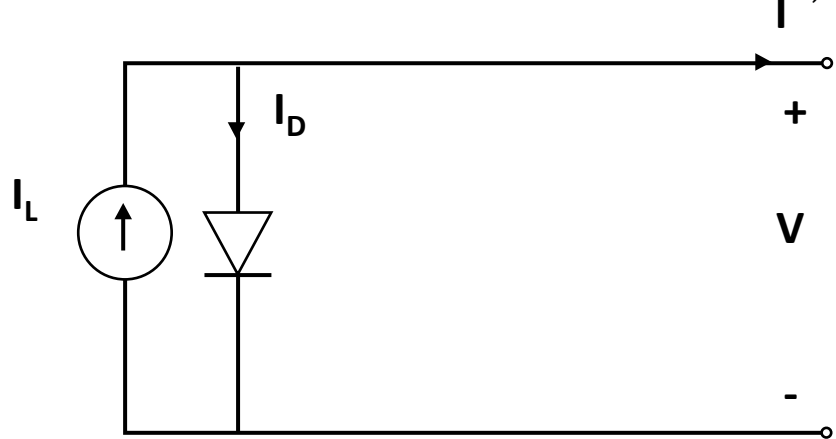
# Modeling steps

## 5. Module and String IV Curve

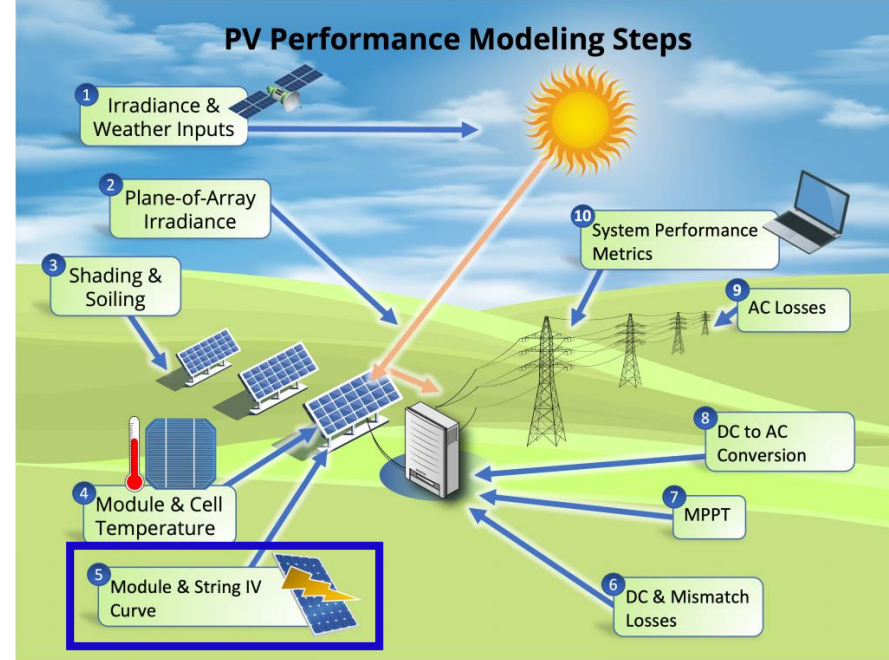
Equivalent-circuit model



Model 1 diode – 3 parameters  $I_L, I_0, a$



$$I = I_L - I_0 \cdot \left( \exp\left(\frac{V}{a}\right) - 1 \right)$$



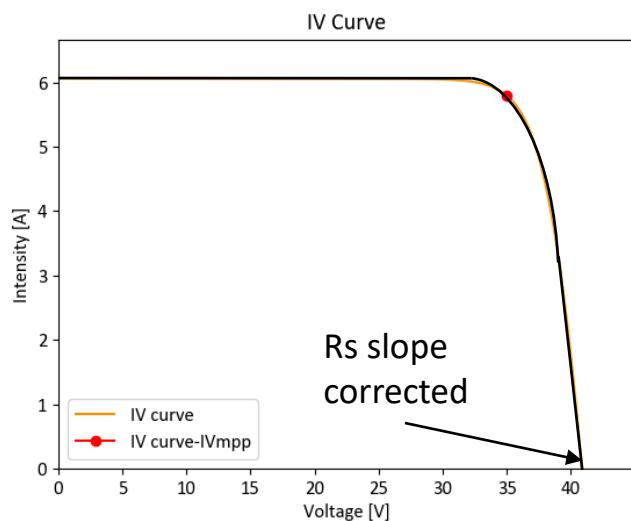
In parallel of the photocurrent  $I_L$  that is generated according to the irradiance, the model:

- Assumes that the PV module acts as a diode

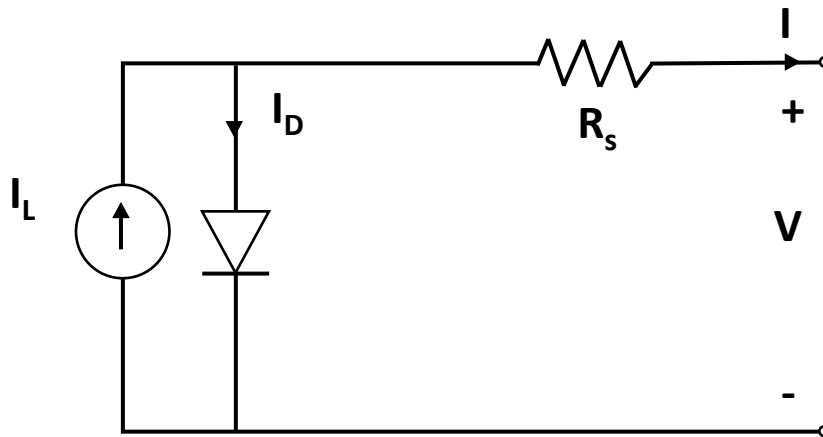
# Modeling steps

## 5. Module and String IV Curve

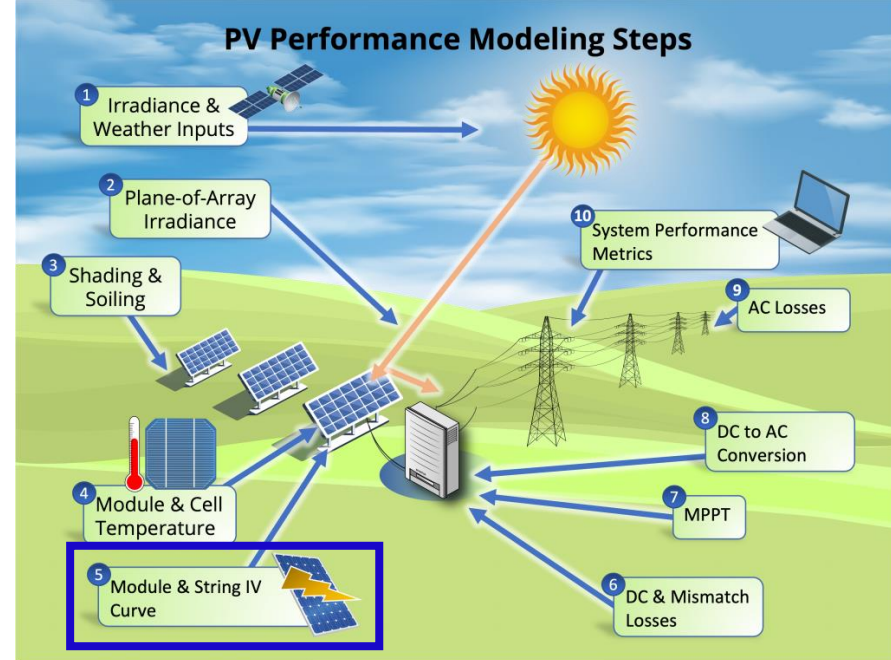
Equivalent-circuit model



Model 1 diode – 4 parameters  $I_L, I_0, a, R_s$



$$I = I_L - I_0 \cdot \left( \exp\left(\frac{V + I \cdot R_s}{a}\right) - 1 \right) + I \cdot R_s$$



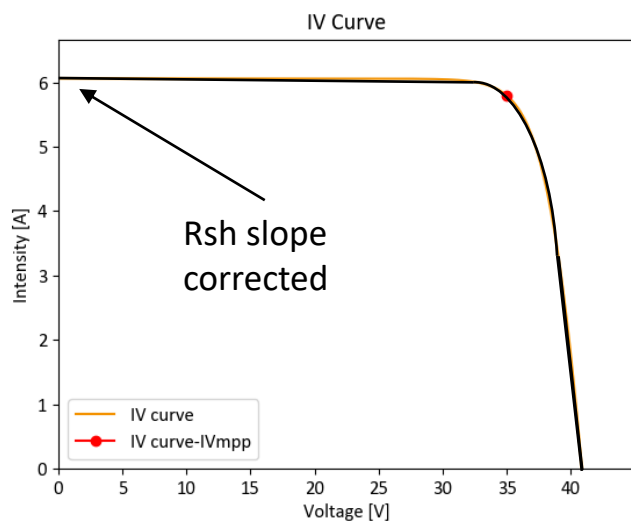
In parallel of the photocurrent  $I_L$  that is generated according to the irradiance, the model:

- Assumes that the PV module acts as a diode
- Estimates the conduction losses

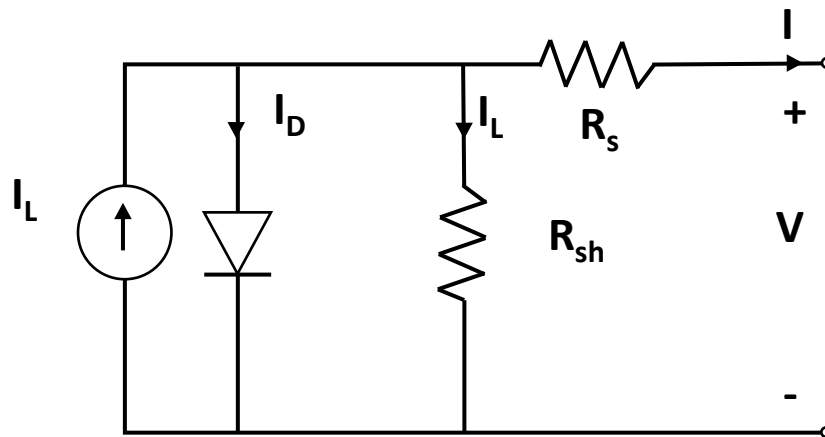
# Modeling steps

## 5. Module and String IV Curve

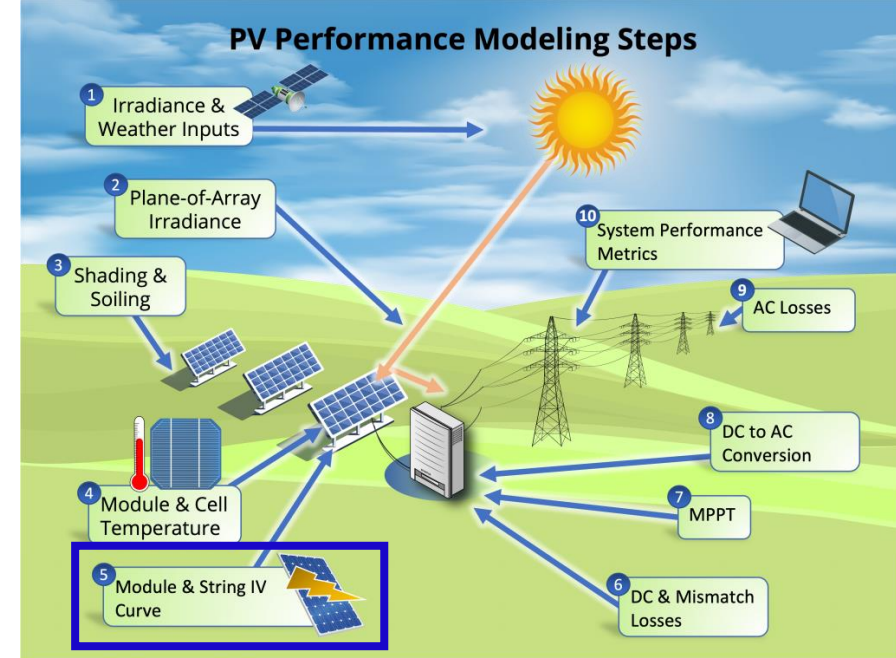
Equivalent-circuit model



Model 1 diode – 5 parameters  $I_L, I_0, a, R_s, R_{sh}$



$$I = I_L - I_0 \cdot \left( \exp \left( \frac{V + I \cdot R_s}{a} \right) - 1 \right) + \frac{V + I \cdot R_s}{R_{sh}}$$

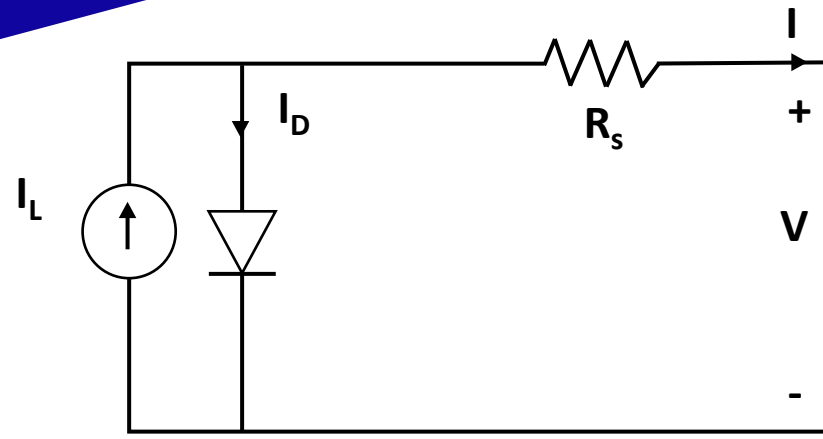


In parallel of the photocurrent  $I_L$  that is generated according to the irradiance, the model:

- Assumes that the PV module acts as a diode
- Estimates the conduction losses
- Estimates the leakage current (going through the module frame or others)

## Modeling steps

### 5. Module and String IV Curve



$$I = I_L - I_0 \cdot \left( \exp\left(\frac{V + I \cdot R_s}{a}\right) - 1 \right) + \frac{V + I \cdot R_s}{R_{sh}}$$

Les 5 parameters  $I_{L,STC}$ ,  $I_{0,STC}$ ,  $R_{s,STC}$ ,  $a_{STC}$ ,  $R_{sh,STC}$  are the 5-parameters at conditions STC ( $G_{STC} = 1000 \frac{W}{m^2}$  et  $T_{STC} = 25^\circ C$ ).

Then, the parameters at environmental conditions ( $G$ : POA irradiance,  $T_c$ : Cell temperature) vary according to the following relationships

**It expects temperatures in Kelvin !**

- i. The photocurrent [A]  $I_L = \frac{G}{G_{STC}} \cdot (I_{L,STC} + \alpha_{sc} \cdot (T_c - T_{STC}))$
- ii. The reverse saturation current [A]  $I_0 = I_{0,STC} \cdot \left(\frac{T_c}{T_{STC}}\right)^3 \exp\left(-\frac{1}{k} \left(\frac{E_g(T_c)}{T_c} - \frac{E_g(T_{STC})}{T_{STC}}\right)\right)$
- iii. The series resistance [ $\Omega$ ]  $R_s = R_{s,STC}$
- iv. The product of the diode ideality factor, number of cells and cell thermal voltage [V]:  $a(T) = \frac{T_c}{T_{STC}} a_{STC}$
- v. The shunt resistance [ $\Omega$ ]  $R_{sh} = R_{sh,STC} \cdot \frac{G_{STC}}{G}$  Corrected on the 10/12/2024
- vi. The silicon energy band in [eV]  $E_g(T_c) = 1,121 \cdot (1 - 0.000267 (T_c - T_{STC}))$

**k**, Boltzmann constant:  $8,617 \times 10^{-5}$  [eV/K]

# Modeling steps

## 5. Module and String IV Curve

Les 5 parameters  $I_L, I_0, R_s, a, R_{sh}$  enable to formulate for any environmental conditions the following equation.

$$I = I_L - I_0 \cdot \left( \exp\left(\frac{V + I \cdot R_s}{a}\right) - 1 \right) + \frac{V + I \cdot R_s}{R_{sh}}$$

# Modeling steps

## 5. Module and String IV Curve

Les 5 parameters  $I_L, I_0, R_s, a, R_{sh}$  enable to formulate:

$$I = I_L - I_0 \cdot \left( \exp\left(\frac{V + I \cdot R_s}{a}\right) - 1 \right) + \frac{V + I \cdot R_s}{R_{sh}}$$

But... the equation resolution is not that direct:

$$I = \frac{I_L + I_0 - \frac{V}{R_{sh}}}{1 + \frac{R_s}{R_{sh}}} - \frac{a}{R_s} W(z)$$

$W$  is the lambert function

With  $z$

$$z = \frac{R_s I_0}{a \left(1 + \frac{R_s}{R_{sh}}\right)} \exp\left(\frac{R_s \cdot (I_L + I_0) + V}{a \left(1 + \frac{R_s}{R_{sh}}\right)}\right)$$



# Modeling steps

## 5. Module and String IV Curve

Les 5 parameters  $I_L, I_0, R_s, a, R_{sh}$  enable to formulate:

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Fortunately,

[https://pvlib-python.readthedocs.io/en/v0.11.1/reference/generated/pvlib.pvsystem.v\\_from\\_i.html#pvlib.pvsystem.v\\_from\\_i](https://pvlib-python.readthedocs.io/en/v0.11.1/reference/generated/pvlib.pvsystem.v_from_i.html#pvlib.pvsystem.v_from_i)

## pvlib.pvsystem.v\_from\_i

```
pvlib.pvsystem.v_from_i(current, photocurrent, saturation_current,
resistance_series, resistance_shunt, nNsVth, method='Lambertw') \[source\]
```

Device voltage at the given device current for the single diode model.

Uses the single diode model (SDM) as described in, e.g., Jain and Kapoor 2004 [1]. The solution is per Eq 3 of [1] except when resistance\_shunt=numpy.inf, in which case the explicit solution for voltage is used. Ideal device parameters are specified by resistance\_shunt=np.inf and resistance\_series=0. Inputs to this function can include scalars and pandas.Series, but it is the caller's responsibility to ensure that the arguments are all float64 and within the proper ranges.

**Changed in version 0.10.0:** The function's arguments have been reordered.

### Parameters:

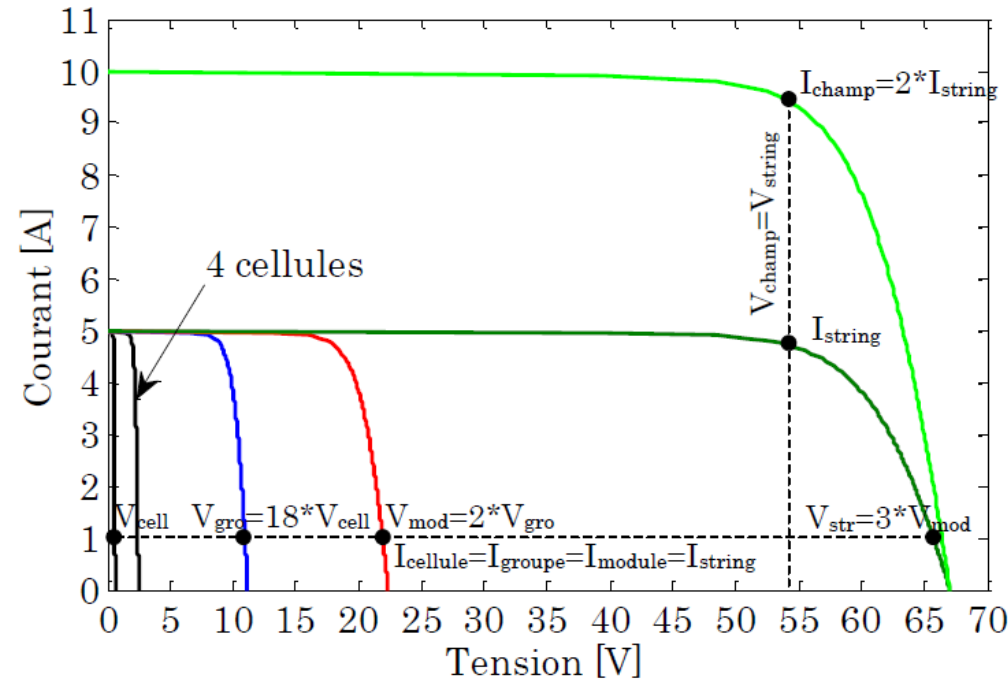
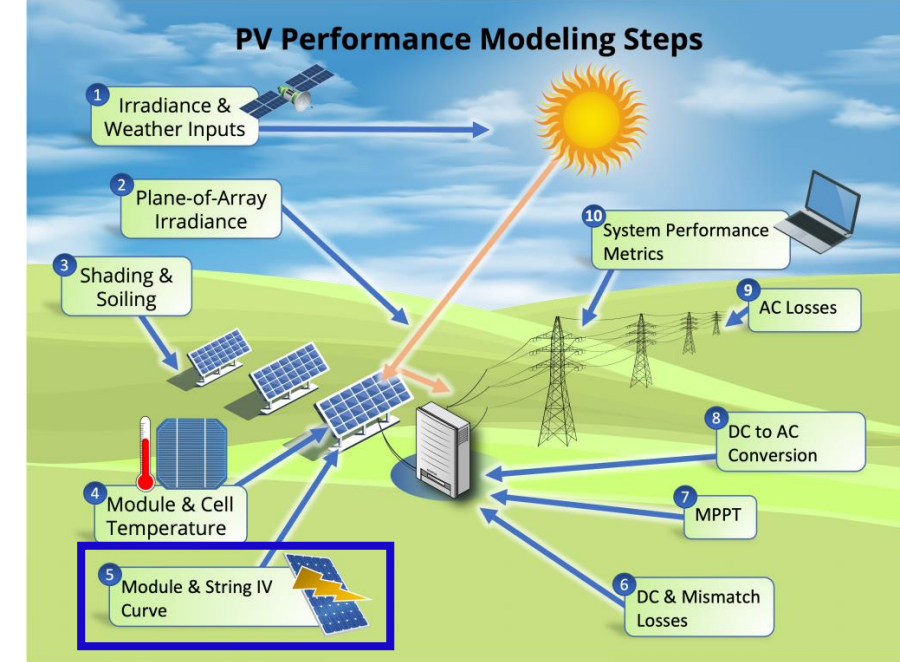
- **current** (*numeric*) – The current in amperes under desired IV curve conditions.
- **photocurrent** (*numeric*) – Light-generated current (photocurrent) in amperes under desired IV curve conditions. Often abbreviated `I_L`.  $0 \leq \text{photocurrent}$
- **saturation\_current** (*numeric*) – Diode saturation current in amperes under desired IV curve conditions. Often abbreviated `I_0`.  $0 < \text{saturation\_current}$
- **resistance\_series** (*numeric*) – Series resistance in ohms under desired IV curve conditions. Often abbreviated `R_s`.  $0 \leq \text{resistance\_series} < \text{numpy.inf}$



# Modeling steps

## 5. Module and String IV Curve / Reminder

By the way... the IV curves can be summed up when the modules are connected in series or parallel! The inverter, then, maximizes the power of the PV array IV curve.



In series, the voltages are added up

In parallel, the currents are added up

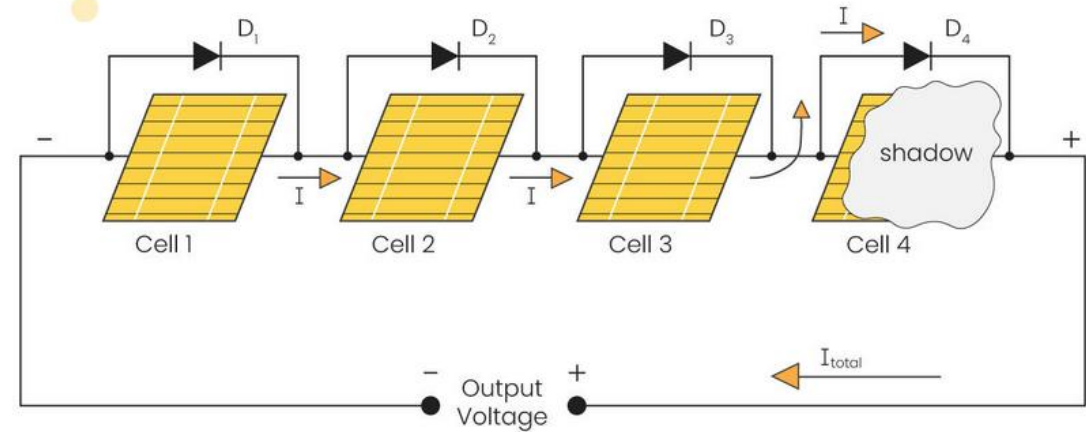
## Modeling steps

### 5. Module and String IV Curve

#### Bypass diodes

Bypass diodes in PV modules are used to handle important mismatch cases such as shading, cell crack, uneven soiling, etc... to prevent significant losses at the module level and high reverse voltages which would induce hotspots at the cell level.

Those are typically Schottky diodes which are commonly 3 (between 2 and 5) per PV module, each in parallel of a group of around 20 cells.



*Bypass diode protection*

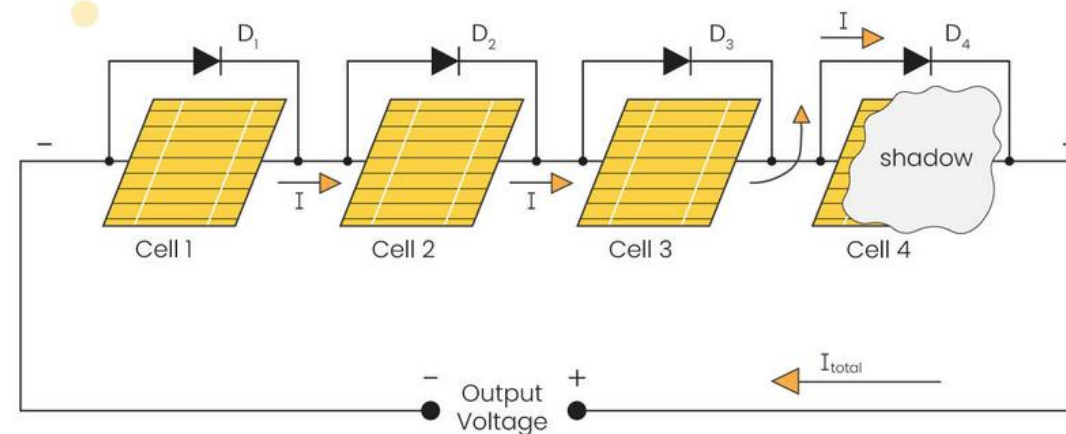
# Modeling steps

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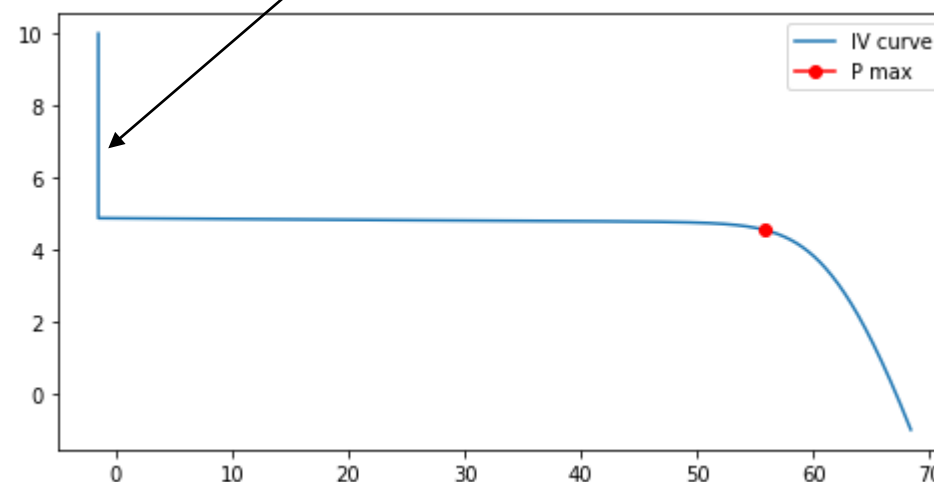


*Bypass diode protection*

### (Ideal) Diode effect:

Around -1.5 V

Limit negative voltages



# How can Machine Learning Tools enable better estimation and failure detection ?

Methods like **Polynomial Regression**, **Decision Trees**, and **KNN** deliver high accuracy when applied to sensible training datasets.

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## PVWatts Model

Perfect use case for **Regression** techniques to optimize  $P_{dc0}$  and  $\gamma_{pdc}$  to minimize model errors.

$$P_{dc} = P_{dc0} \cdot \frac{G_{POA}}{1000 \text{ W/m}^2} \cdot \left(1 + \gamma_{pdc} \cdot (T_{cell} - 25^\circ\text{C})\right)$$

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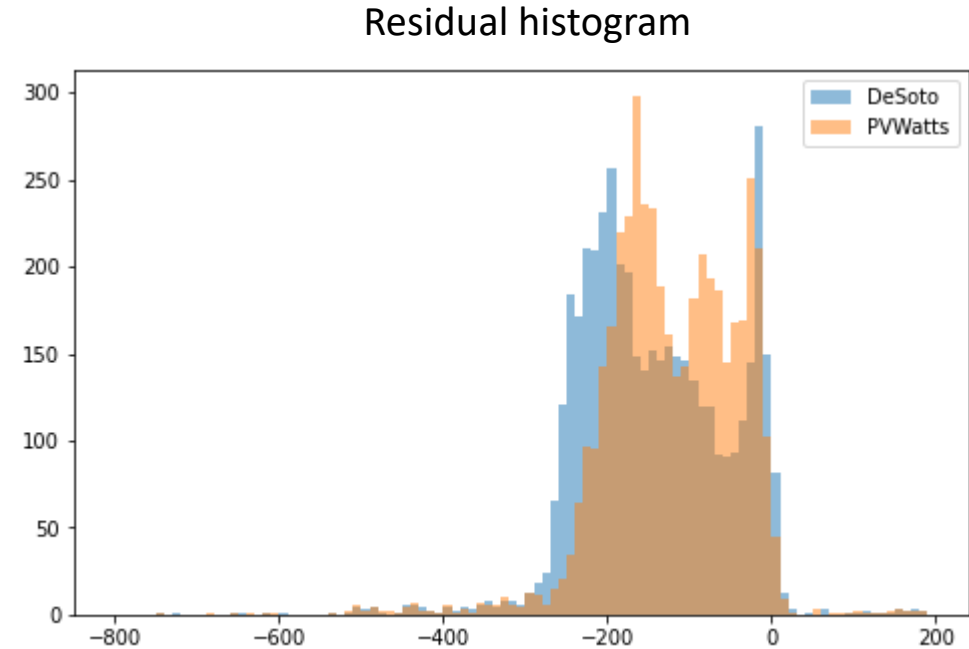
## PVWatts Model

Perfect use case for **Regression** techniques to optimize  $P_{dc0}$  and  $V_{pdc}$  to minimize model errors.

## Importance of Residual Analysis:

Always analyze residuals (**actual – model**) values to:

- Identify biases using **histograms** or **scatter plots**.
- Understand model limitations.
- Add **post-processing layers** for error correction.



- Residual mainly contained between -500 W and 0W
- Constant biases
- Two/Three local peaks

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## PVWatts Model

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## Error Metrics :

### Mean Error

$$ME = \frac{1}{n} \sum_i^n O_i - P_i$$

### Mean Absolute Error

$$MAE = \frac{1}{n} \sum_i^n |O_i - P_i|$$

- $O_i$ : Observed value at instance i.
- $P_i$ : Predicted value at instance i.
- n: Total number of observations.

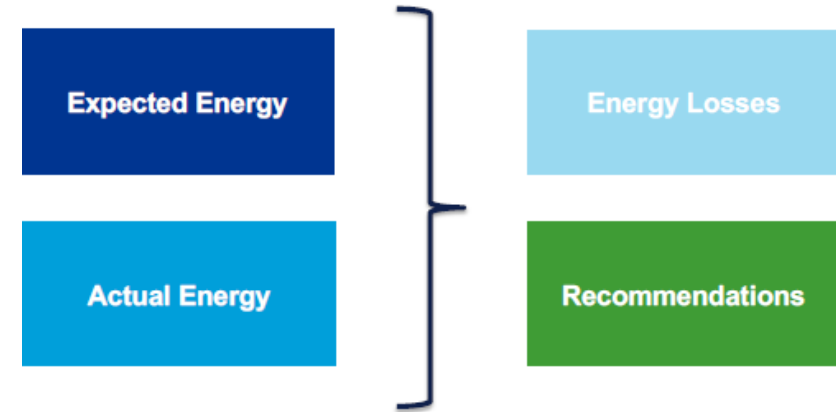
## Failure detection: Few insights



# Failure detection: Few insights

## Threshold-Based Approach:

- Sets predefined performance thresholds.
- Failure Identification: Flags deviations when performance metrics (e.g., voltage, current) exceed the thresholds

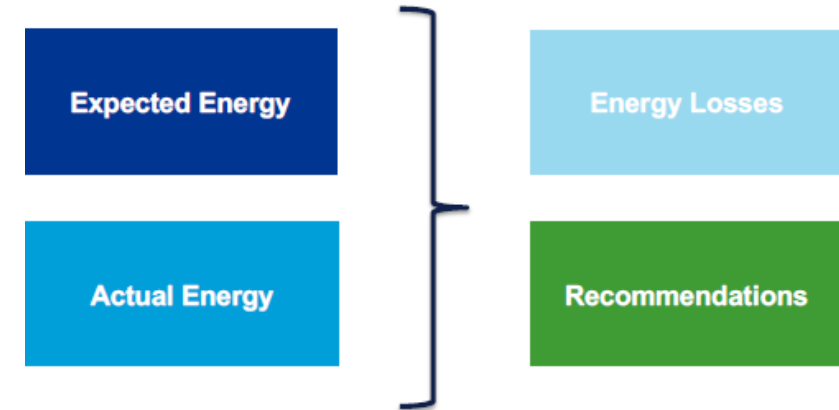


Reference image: DNV

# Failure detection: Few insights

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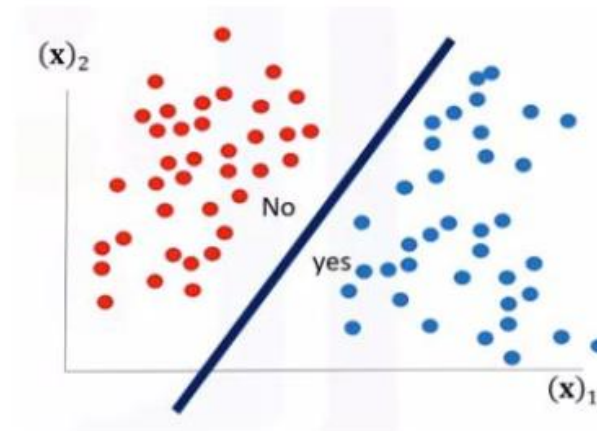
Reference image: DNV

## Unsupervised Learning:

Detects anomalies by clustering or analyzing patterns without labeled data.

### Common Techniques:

- K-Means Clustering
- Principal Component Analysis (PCA)



Reference image: The Use of Advanced Algorithms in PV Failure Monitoring 2021, IEA Report

## Modeling steps

Implement the 1-diode parameter model, improve the accuracy of DC power models and detect underperformances

<https://colab.research.google.com/drive/1nADZ1DH7rbXfohQS8HPEDMRc8VrOuh-1?usp=sharing>

Time for some  
hands-on exercises !



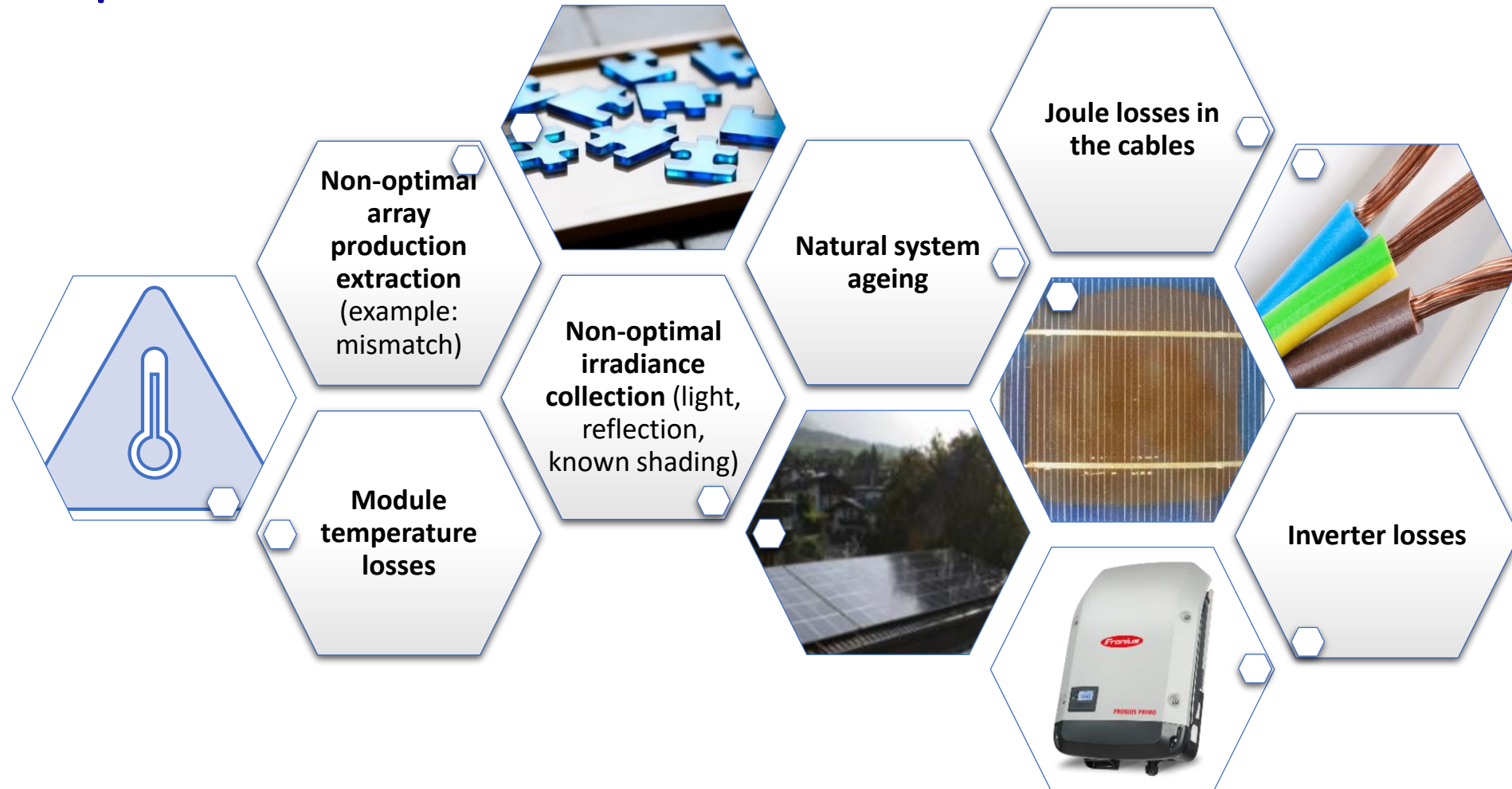
# Agenda



**PV « expected » losses**

# Wooclap survey

# PV « expected » losses



# Agenda



## PV Failure

# PV failure definition

Inspired from the IEA definition\*, a failure occurs when\*\*:

$$P_m(t) + \Delta P_m(t) < P_{expected}(t) - \Delta P_{expected}(t)$$

$P_m(t)$  the system power measured according to IEC 60904

$\Delta P_m(t)$  the total uncertainty of the measurement

$P_{expected}(t)$  the expected system power

$\Delta P_{expected}(t)$  the expected system power tolerance

In other words, a failure is an underperformance which is not planned at the design phase.

\*M. Köntges et al., “Review of Failures of Photovoltaic Modules,” IEA PVPS T13, IEA-PVPS T13-01:2014, 2014.

\*\*A. Mathieu, G. Fraisse, M. Thebault, S. Thebault, S. Boddaert, and L. Gaillard, ‘Failure Risk Analysis of Photovoltaic Systems Based on Literature Review’, presented at the Eurosun 2022, Kassel, Germany, Sep. 2022.



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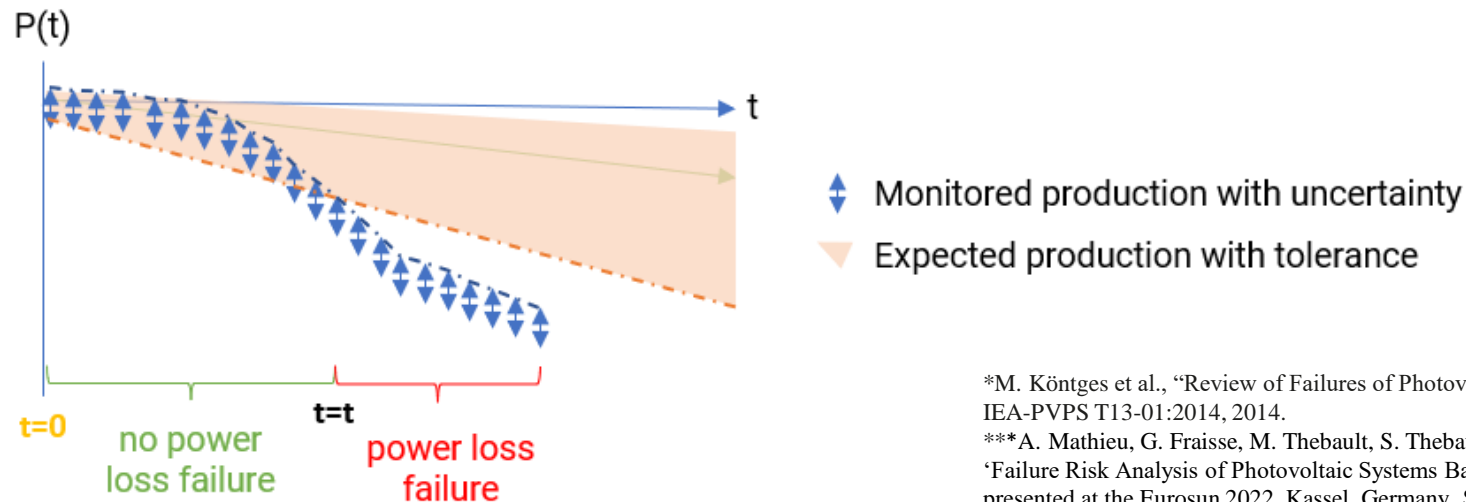
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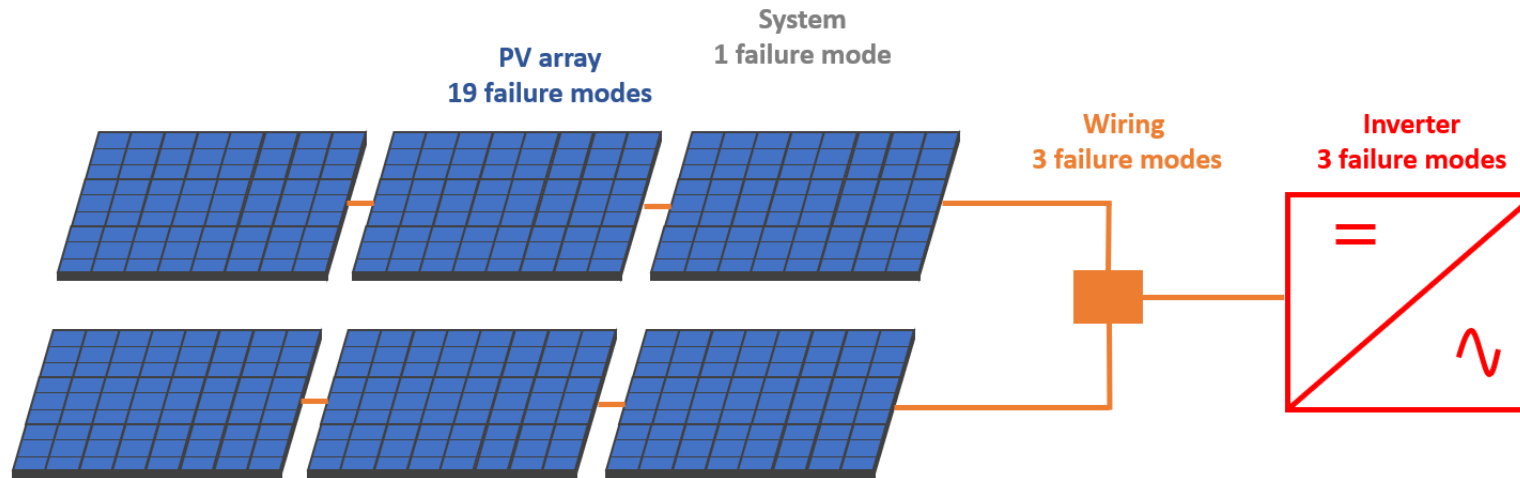


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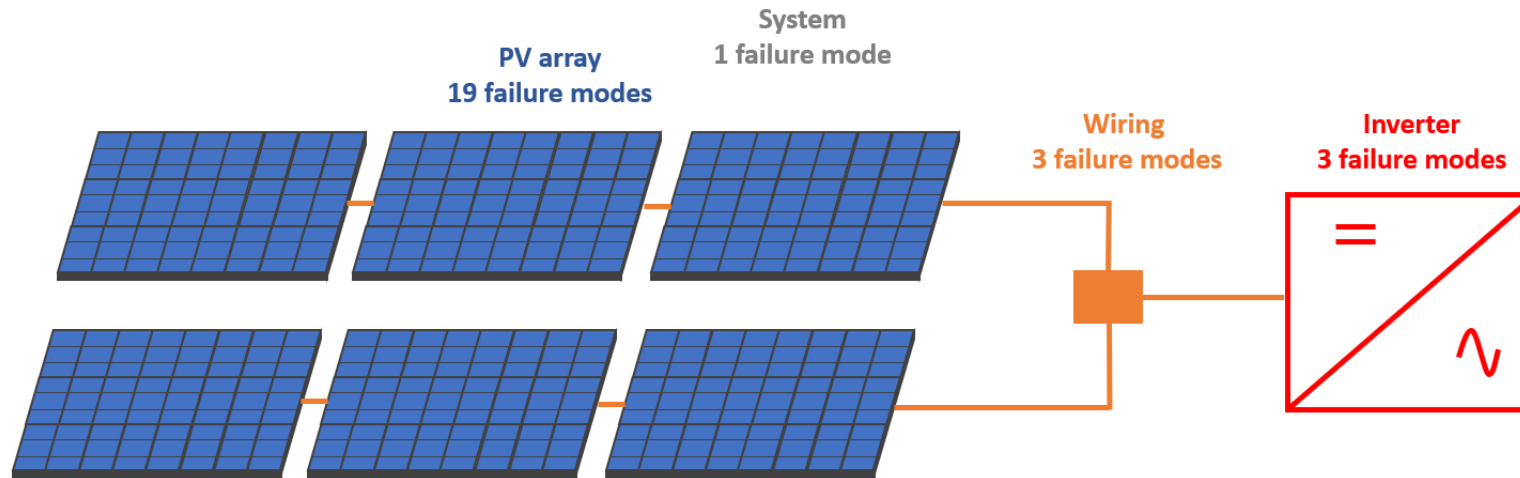
# Failures

One list of failures...  
Total: **26**



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Total: **26**



| System  | Module/Array   |
|---|--|
| Insulation failure and ground connection defect | Backsheet degradation  |
|   | Burn marks   |
|   | Bypass diode defect  |
|   | Cell cracks  |
|   | Cell interconnection defect  |
|   | Corrosion  |
|   | Delamination   |
|   | Encapsulant degradation  |
|   | Frame/Mounting structure defect  |
|   | Glass breakage   |
|   | Hot spot   |
|   | Junction box defect  |
|   | Light Induced Degradation (LID) and Light and elevated Temperature Induced Degradation (LETID) |
|   | Module under-ventilation   |
|   | Not conform power rating   |
|   | Potential Induced Degradation (PID)  |
|   | Shading  |
|   | Soiling  |

# Failures

One list of failure...

| System  | Module/Array   |
|---|--|
| Insulation failure and ground connection defect | Backsheet degradation  |
|   | Burn marks   |
|   | Bypass diode defect  |
|   | Cell cracks  |
|   | Cell interconnection defect  |
| <b>Inverter</b>                                 | Corrosion  |
| Inverter defect                                 | Delamination   |
| Inverter overheating                            | Encapsulant degradation  |
| Unexpected inverter derating                    | Frame/Mounting structure defect  |
|   | Glass breakage   |
| <b>Wiring</b>                                   | Hot spot   |
| Combiner box defect                             | Junction box defect  |
| Connector defect                                | Light Induced Degradation (LID) and Light and elevated Temperature Induced Degradation (LETID) |
| DC cable defect                                 | Module under-ventilation   |
|   | Not conform power rating   |
|   | Potential Induced Degradation (PID)  |
|   | Shading  |
|   | Soiling  |

The 12 most critical according to \*

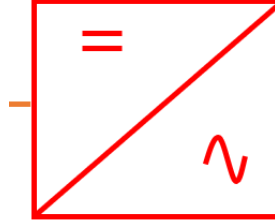
# Agenda



## Common PV Failures

# Inverter defect

Inverter  
3 failure modes



The inverter is often responsible for most of the maintenance events. Several failures can occur over the inverter lifespan due to unexpected events or aging mechanisms.

The most common failures in the inverter due to aging come from components such as the relays, the capacitors, the semiconductor modules (IGBT and diodes), cooling fan, and the printed circuit board.

Software issues or a lack of restart after an event can also shut down the inverter and can be solved by rebooting the software or updating the firmware.



K. Sinclair, M. Sinclair, "Silicon solar module visual inspection guide: Catalogue of Defects to be used as a Screening Tool"

## Detection Hints:

- Abrupt performance drop from a specific date.
- Complete shutdown: Produces 0 W.

# Inverter clipping

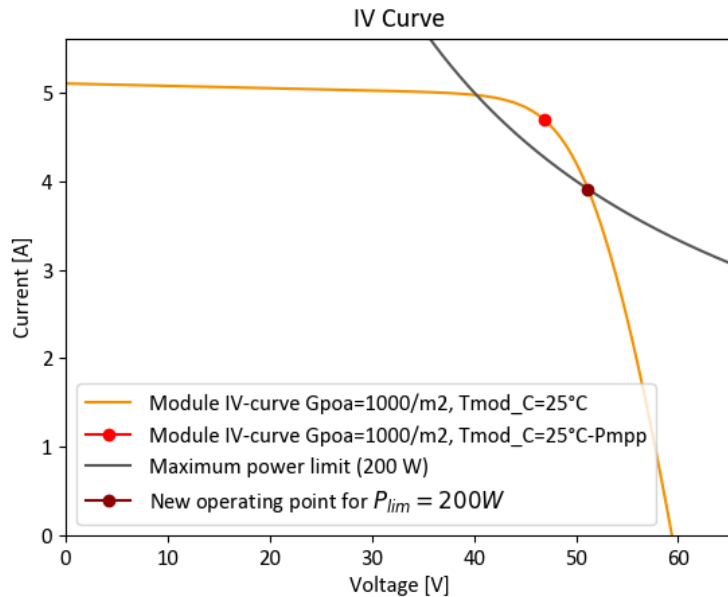
« Inverter clipping » occurs when the generated DC power exceeds the inverter limit.

Then, the inverter caps the generated DC power by moving the operating point to reduce the DC production and fit within the inverter input limits.

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Example where the inverter increases the tension to reduce the DC power.

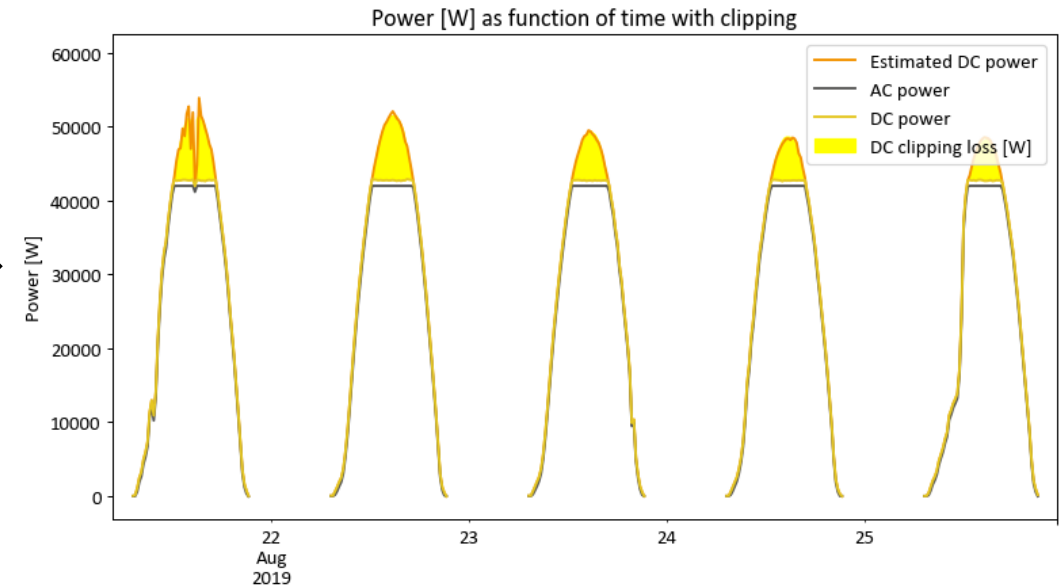
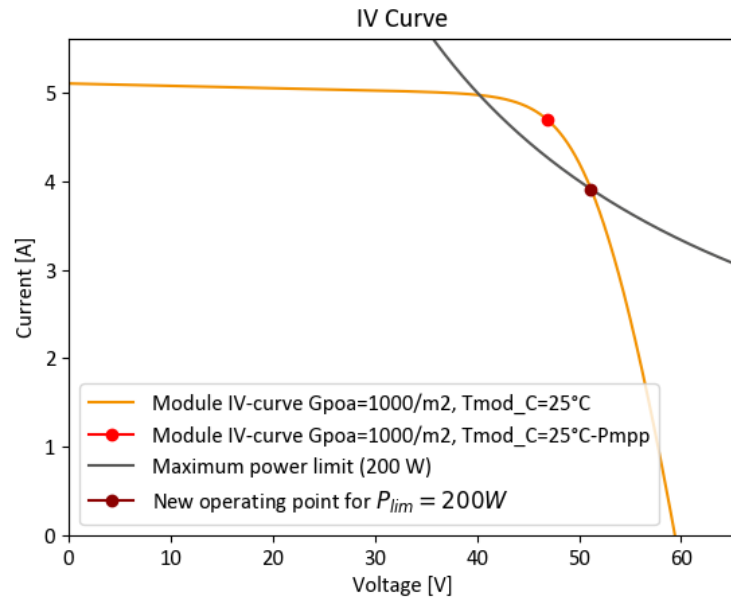


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## Signature



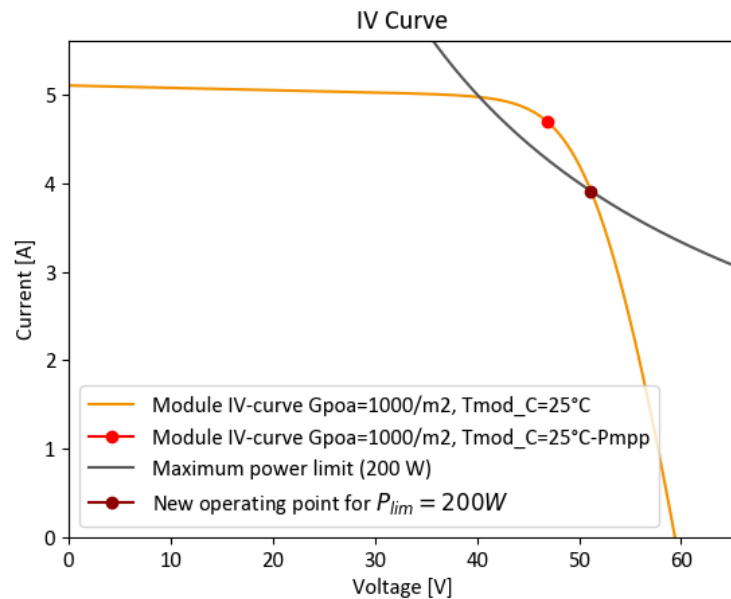
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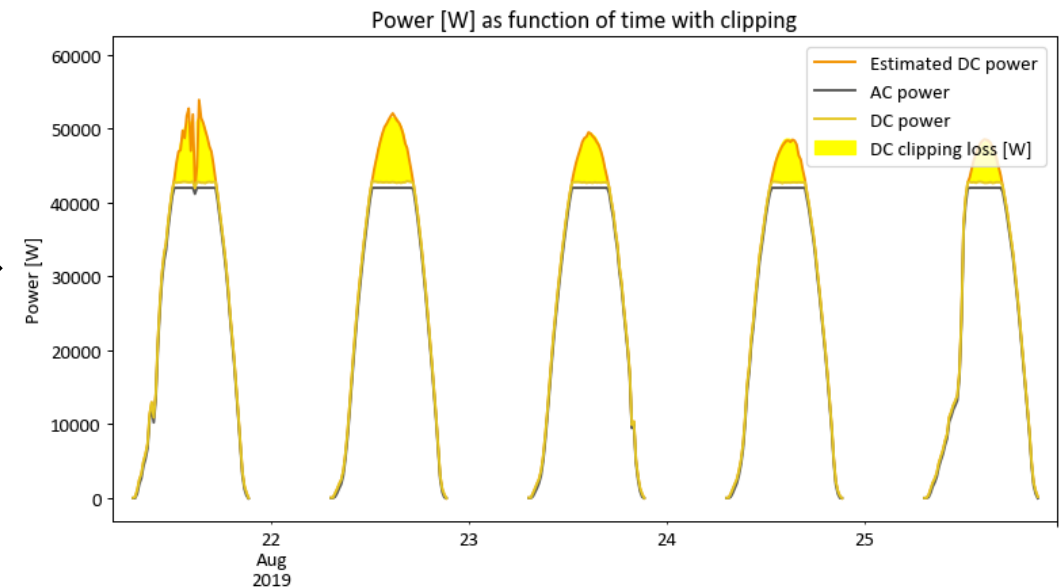
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## Detection Hints:

- Clipping threshold is generally fixed.
- Occurs at high sunny conditions.
- Power Slope = 0 W/m<sup>2</sup>/h.
- Slight increase of voltage compared to standard operation.
- Current loss.

# Cable/Connector defect: Open-circuited string

Wiring defect might lead to fire.

**DC cable** failure can occur due to various reasons at different phases.

- At the design phase, cables which are incorrectly dimensioned may result in overheating and early cable degradation.
- During the installation, pinching or pulled cables can also lead to early defects.
- During the exploitation, DC cables might also deteriorate faster or might corrode if exposed to harsh environments such as UV radiation, rodents, or birds.

**Connector** failures come typically from forcing different types of connectors to connect or not-well crimped connectors.

Even if aging mechanisms with corrosion due to long exposure to weather with UV and humidity are identified for connectors, failures are most likely to be related to installation issues.



Images. M. Köntges et al. , Review of Failures of Photovoltaic Modules, Report IEA-PVPS T13-01: ISBN 978-3-906042-16-9, 2014.



## Detection Hints:

- Abrupt performance change from a specific date
- The voltage is not expected to vary.
- Loss of current proportional to the number of strings which are open-circuited.

# Shading

Shading refers to the obstruction of sunlight on the PV array.

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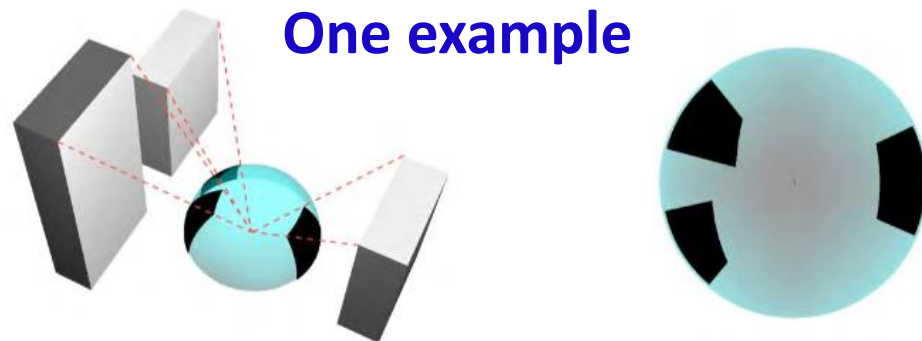


Image: "Measuring sky view factor of urban canyons using hacked Gopro hemispheric video processing",  
December 2015, Conference, Melbourne, Australia, White et Kimm

# Shading / Full shading

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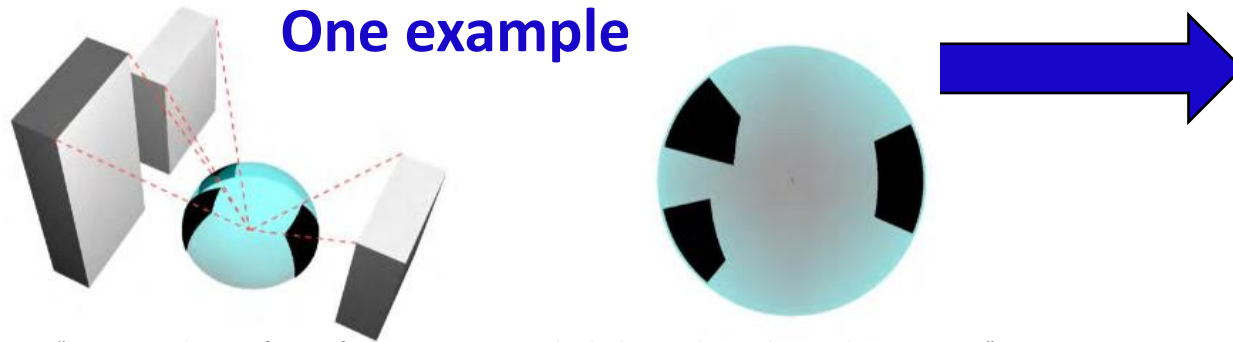
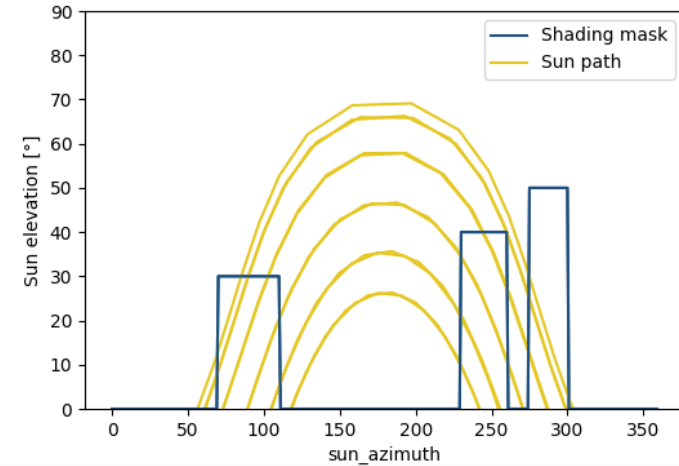


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\*Process illustration, assumptions made on the building masks.

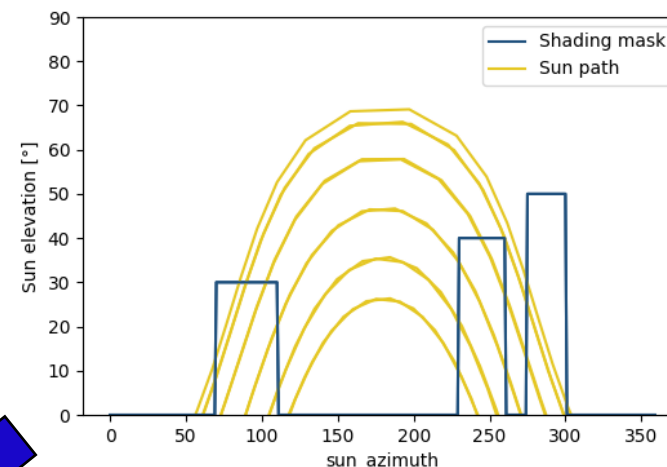
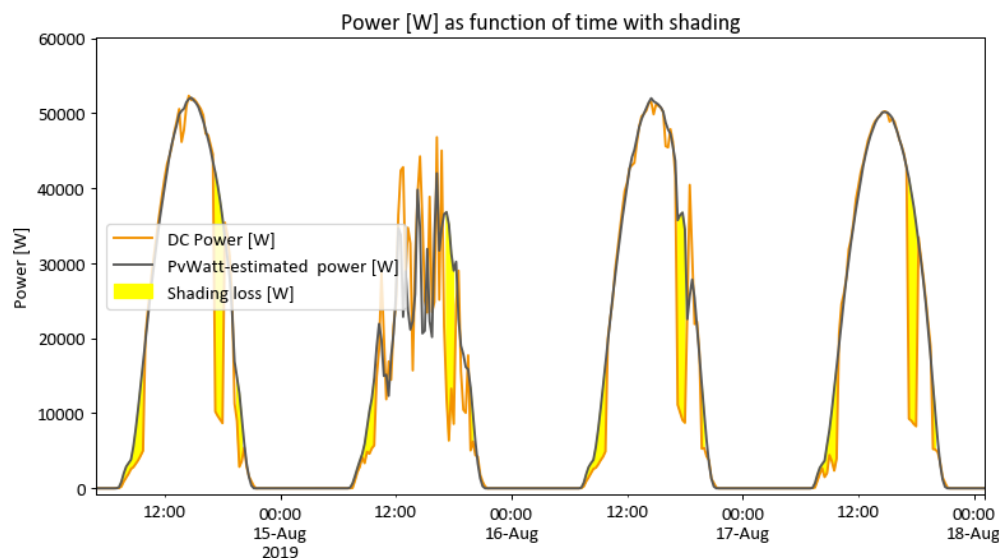
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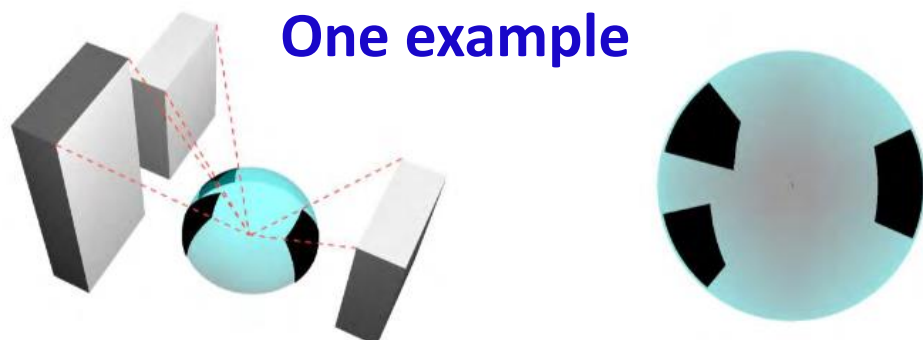
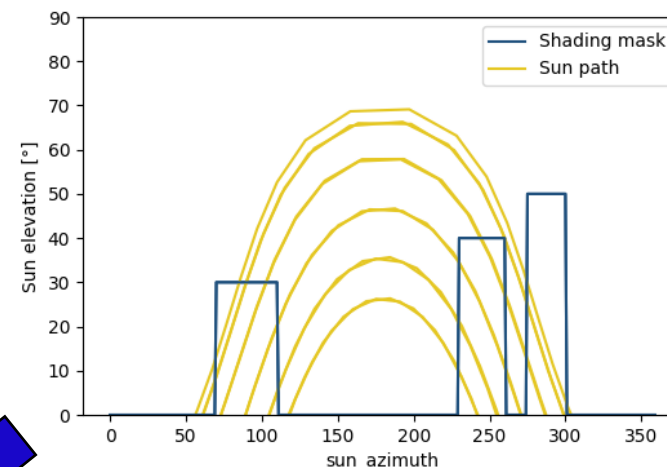
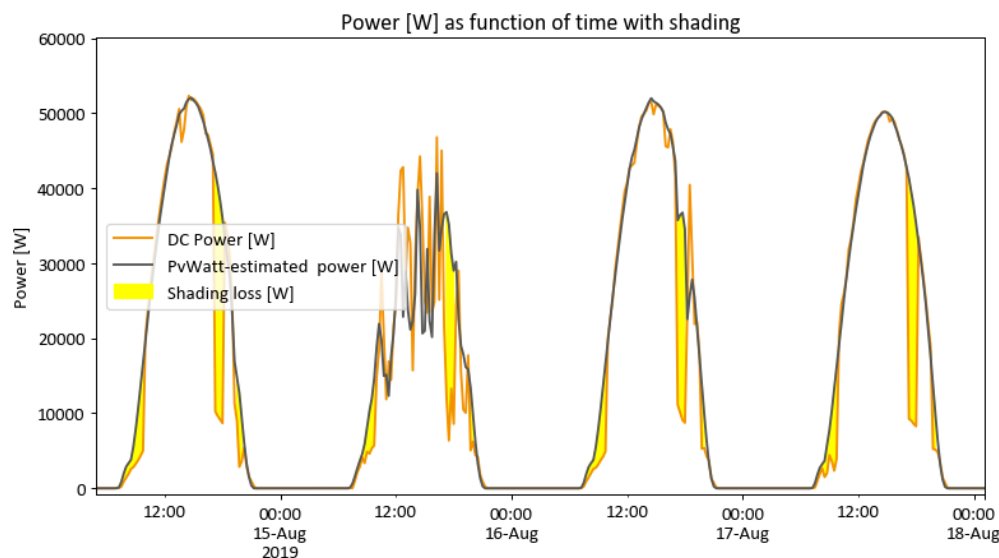


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## Detection Hints:

- Temporal cycle
- Correlated with the sun position (Low sun horizons have higher chances to result in shading.)
- Power/Current decrease in the same order of magnitude as the POA-direct component vs POA-global
- Sudden drops/increase



## Bypass short-circuit

Diode failures can appear at different stages:

- **Manufacturing:** wrong specification, non-functional diode..
- **Installation:** Wrong installation (inversed or not properly connected), mechanical stress on junction boxes, shocks. . .
- **Operation:** Diode aging mechanisms, junction box corrosion, events with mechanical stresses, repetitive activation (partial shadings).

Failed diodes are either blocked in short-circuit or open-circuit.



Image reference: Romenia G. Vieira et al. "A Comprehensive Review on Bypass Diode Application on Photovoltaic Modules". In: Energies 13.10 (2020)

### Detection Hints:

- Short-circuited bypass diodes constantly lower the module voltage by around 1/3 if there are 3 diodes in the module.
- Abrupt performance change from a specific date

*That's it*

